

# Power consumption analysis and optimization

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Author e-mail:[cl@rock-chips.com](mailto:cl@rock-chips.com)

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## Preface

### Overview

This document mainly describes some basic concepts and optimization methods of power consumption for RK platform chips.

### Product version

Product name	Kernel version
All chips	All kernel versions

### Applicable object

This document (the guide) is mainly suitable for below engineers:

Field application engineers

Software development engineers

### Revision history

Date	Version	Author	Revision description
2019.08.31	V1.0	Chen Liang	Initial version

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## Power consumption analysis and optimization

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## 1. Basic concept

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### 1.1 Frequency (clk) and voltage

Generally there are many modules inside SoC, such as ARM, GPU, DDR, I2C, SPI, USB and so on. When each module is working, the digital logic part requires an appropriate frequency and corresponding voltage. The higher the module frequency is, the higher the voltage is required. The frequency and voltage are two important parameters of power consumption.

### 1.2 Voltage domain(VD) and power domain(PD)

Generally all modules inside SoC have digital logic part and IO part. The digital logic part is mainly responsible for computing and status control, and IO part is mainly responsible for the transmission of the interface signal (some modules don't have IO, such as ARM, GPU, etc.). Generally the power supplies of the digital logic and IO are separated. The power consumption of IO part is generally fixed, while the power consumption of digital logic part changes a lot due to the influence of frequency and voltage. In order to optimize the power consumption, the digital logic part inside the chip is divided into voltage domain and power domain according to the module.

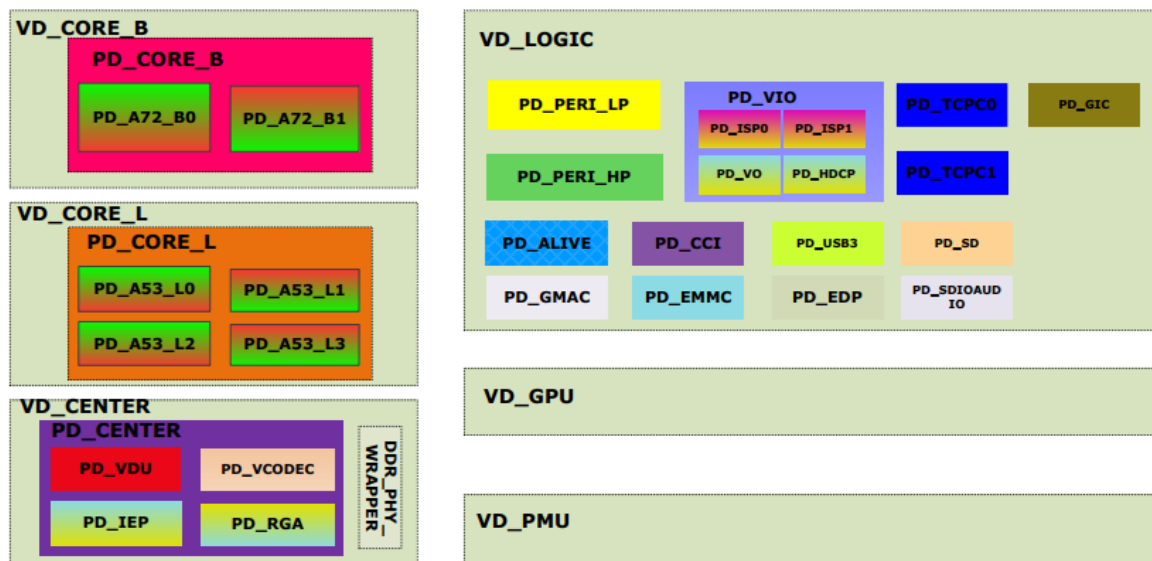
- The voltage domain means the domain where several modules inside the chip share one external power supply. It can adjust or turn on/off the voltage independently. Generally the modules with similar running voltage and not large power consumption can be put in the same voltage domain. But if the power consumption is very large, it is better to use a separate voltage domain, which is convenient to manage the power consumption and also avoid the peak current exceeding the limit of external power supply. To ensure that all modules can work normally, need to set the voltage of the voltage domain to the required voltage of the module with the highest voltage requirement (excluding the closed module).
- One voltage domain may contain many modules and these modules generally don't work at the same time. With power supply, the modules not working will have leakage. In order to reduce the leakage, generally we will divide one voltage domain into several areas, and each area can independently turn on/off the power supply. After some area switches off the power supply, it will be isolated from other modules and significantly reduce the leakage. This kind of area is called power domain.

Take RK3399 as example, there are 6 VD:

- VD\_CORE\_B: including two big cores Context-A72, the power consumption is relatively large, so separate a voltage domain.
- VD\_CORE\_L: including four little cores Context-A53, the power consumption is relatively large, so separate a voltage domain.
- VD\_LOGIC: including some peripherals' controller and system bus, such as USB, EMMC, GMAC, SPI, I2C, EDP, VOP, AXI, AHB, APB, and so on.
- VD\_CENTER: including vdpu, vepu, iep, rga and DDR controller.
- VD\_GPU: including GPU, the power consumption is relatively large, so separate a voltage domain.
- VD\_PMU: including PMU, SRAM, GPIO, PVTM and other modules relating to suspend and resume process.

The block diagram is as below:

### Mclaren power domain & voltage domain



**Note :**  
**VD\_\*** : voltage domain  
**PD\_\*** : power domain

## 1.3 DCDC (Direct Current) and LDO (Low dropout regulator)

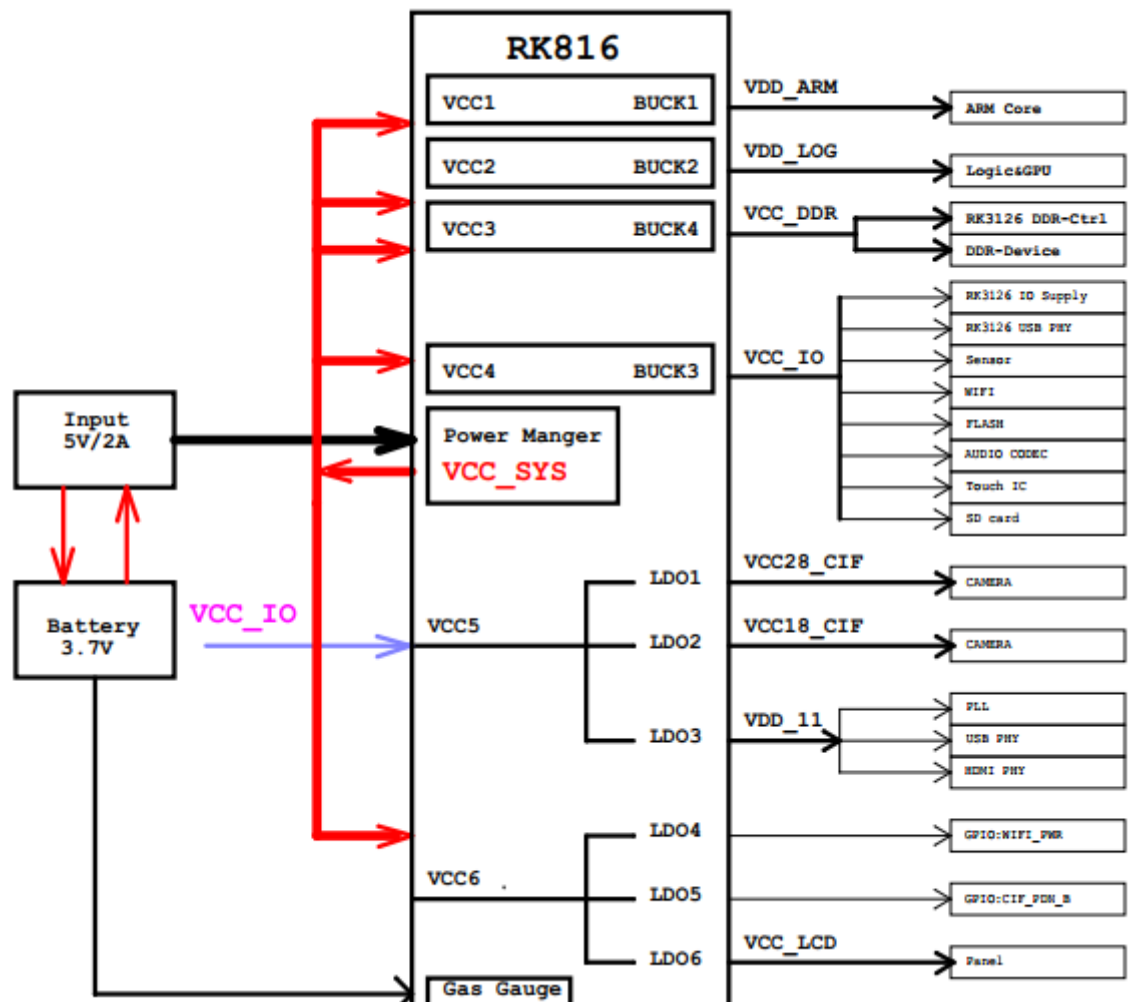
The external power supply of SoC mainly includes DCDC and LDO:

- DCDC generally means switch power, conversion efficiency is high, the efficiency can be up to 80%~90%, when the current is relatively large, need to use DCDC to improve the power efficiency.
- The main characteristic of LDO is, the input current equals to output current, so power efficiency = (output voltage)/(input voltage). Assuming input 3.8V, output 1.0V, the power efficiency is  $1V/3.8V=26.3\%$ , which indicates this is low efficiency.

Take the power supply solution of RK3126+RK816 as example:

- 4 BUCK of RK816 separately supply power for ARM, LOG, DDR, IO of RK3126, because the current of these modules are all relatively large (BUCK is a kind of voltage drop DCDC).
- 6 LDO of RK816 separately supply power for PLL, PHY and some peripherals of RK3126, because the current of these modules are relatively small.

The block diagram of the power supply is as below:



## 1.4 Static power consumption and dynamic power consumption

- The static power consumption is the power consumption consumed by the leakage of transistor when the internal modules of SoC are not working. The static power consumption will increase with the increase of the temperature and voltage.
- The dynamic power consumption is the power consumption consumed by the conversion of internal circuit when the internal modules of SoC are working. The dynamic power consumption will increase with the increase of the frequency and voltage.

```

1 The format of dynamic power consumption:
2 /* C is constant, v is voltage, F is frequency*/
3 P(d)= C * V^2 * F

```

## 1.5 DVFS(Dynamic Voltage and Frequency Scaling), CPUFREQ and DEVFREQ

The higher the module working frequency and the voltage are, the higher the power consumption is. So need dynamically adjust the frequency and voltage to optimize the power consumption. When the system is idle, reduce the frequency and voltage, when the system is busy, increase the frequency and voltage.

- DVFS is the technology of dynamic voltage and frequency scaling, which is the basic technology implementation of CPUFREQ and DEVFREQ.
- CPUFREQ is the software framework of dynamic CPU frequency scaling, including several different frequency scaling strategies. For more details, please refer to the document

《Rockchip-Developer-Guide-Linux4.4-CPUFreq-CN》.

- DEVFREQ is the software framework of dynamic peripheral(not including CPU) frequency scaling, including several different frequency scaling strategies. For more details, please refer to 《Rockchip-Developer-Guide-Linux4.4-Devfreq》.

## 2. Power consumption measurement

Before optimizing the power consumption, need to measure the voltage and current of each power supply, analyze the data and then optimize accordingly.

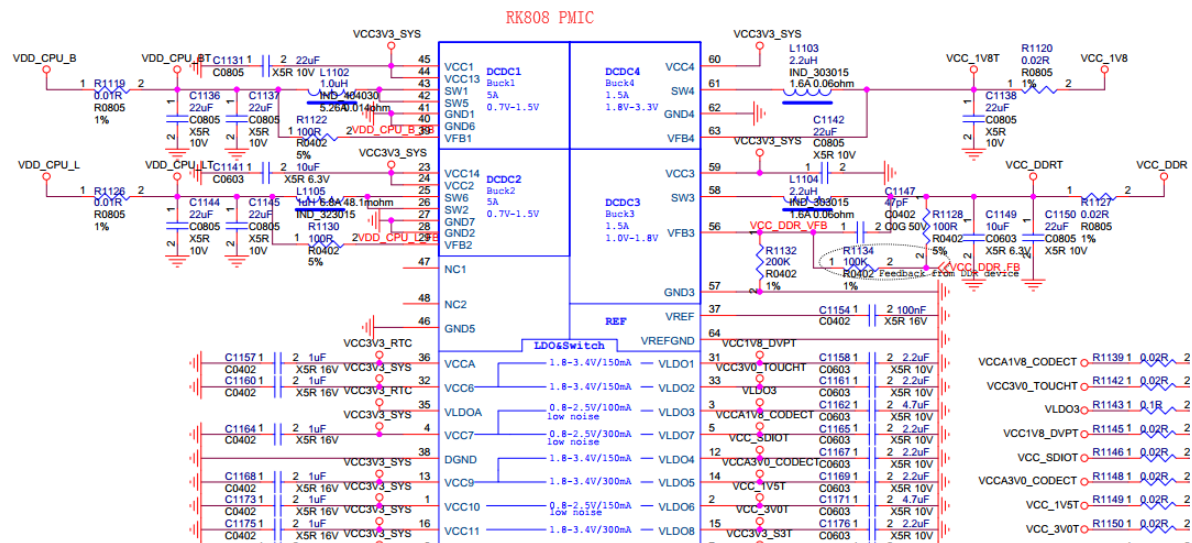
*Note: the temperature is an important parameter affecting the power consumption, so need to record the real-time temperature when measuring the power consumption. The command to acquire the temperature is as below:*

```
1 | cat /sys/class/thermal/thermal_zone0/temp
```

### 2.1 Measurement method

Series connect a resistor R in the circuit to measure the voltage difference U between two sides of the resistor, then the current  $I=U/R$ . Generally here we use the resistor with 0.01 ohm, but you need to adjust the resistance according to the current.

Take RK3399 EVB board as example, by this method, series connect 0.01 ohm resistor to the output of VDD\_CPU\_B, VDD\_CPU\_L, VCC\_1V8 and VCC\_DDR, as shown in below picture:



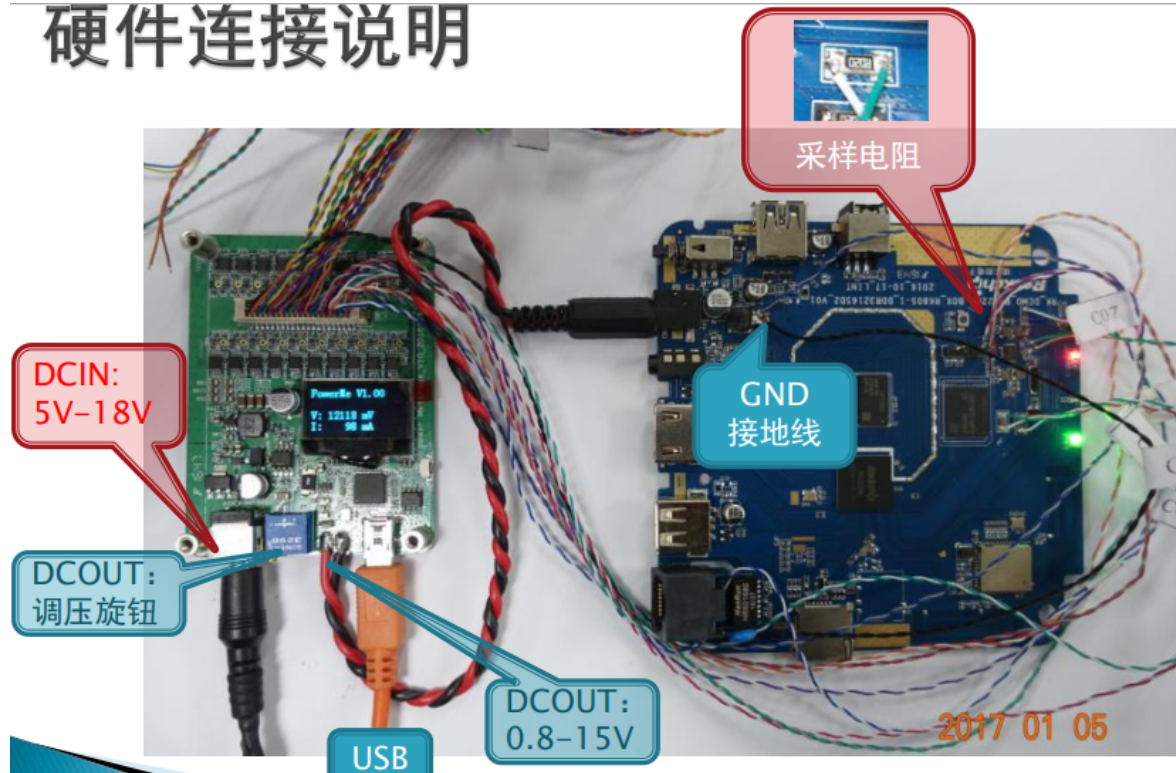
### 2.2 Measurement tool

As there are many channels of power required to be measured, use multi-channel voltage/current collector can effectively improve the testing efficiency. PowerMeterage is the voltage/current collection tool developed by RockChip and it can measure 20 channels of power consumption data at the same time. The interface is as below:

RK3399 (Sample:13094 1212 Sample/S 00:00:10)												
Name	12V	VSYS	VCC3V3_SYS	VDD_CPU_B	VDD_LOG	VDD_CPU_L	VDD_CENTER	VCC_DDR	VCC_1V8	VDD_CPU		
Avg	11.891V	258.4mA	5.048V	565.3mA	3.431V	91.1mA	0.812V	39.9mA	0.94V	292.9mA	0.821V	72.3mA
Rms	11.891V	260.8mA	5.048V	570.6mA	3.431V	91.1mA	0.814V	130.4mA	0.94V	293mA	0.821V	79.9mA
Max	11.92V	523.3mA	5.075V	1156.9mA	3.435V	104.4mA	1.145V	1609.1mA	0.941V	319.6mA	1.074V	425.6mA
Now	11.894V	249.5mA	5.047V	548.9mA	3.431V	91.1mA	0.8V	9.2mA	0.94V	292.2mA	0.817V	67.1mA
CH/mR	CH:0	50mR	CH:1	50mR	CH:2	50mR	CH:3	50mR	CH:4	50mR	CH:5	50mR
Name	IR_LED	MIP1_B	CAMERA_HOST2	VDD_LCD								
Avg	4.963V	0.1mA	18.345V	4.5mA	5.024V	146.9mA	2.787V	20.8mA				
Rms	4.963V	0.1mA	18.345V	4.5mA	5.024V	147.3mA	2.787V	20.8mA				
Max	4.985V	0.2mA	18.36V	4.7mA	5.051V	160.5mA	2.79V	21.9mA				
Now	4.962V	0.1mA	18.344V	4.5mA	5.024V	146.6mA	2.788V	20.8mA				
CH/mR	CH:10	50mR	CH:11	100mR	CH:12	100mR	CH:13	100mR				

The hardware connection of PowerMeterage is as below:

## 硬件连接说明



### 3. Power consumption data analysis

#### 3.1 Calculate theoretical power consumption

Use PowerMeterage tool to break down the power consumption of each path, convert DCDC to the battery with 80%90% efficiency, the output current of LDO is equal to the input current, convert DCDC, LDO and other powers to the battery, and then add them up to estimate the total power consumption. If it is very different from the power consumption actually measured on the battery, maybe there is leakage. Need to analyze further.

Take RK3326 EVB board as example, the static desktop power consumption is as below:

*Note: Because the test result of each path should be converted to the power consumption of the battery, so it is more convenient to compare the actually measured current of the battery with the theoretical current on battery.*

Type	power-supply	Voltage(V)	current(mA)	Theoretical current on battery-3.8V(mA)	Remark
DC/DC	VDD_ARM	0.96	10.20	3.23	With 80% efficiency, conversion formula: $V * I / \text{efficiency} / \text{voltage of the battery}$
DC/DC	VDD_LOG	0.96	89.30	28.20	eg: Theoretical current of VDD_LOG on battery(3.8V)= $0.96 * 89.3 / 0.8 / 3.8 = 28.2$
DC/DC	VCC_DDR	1.26	38.50	15.91	
DC/DC	VCC_IO	2.99	4.50	4.43	
LDO	VCC_1V8	1.81	28.80	28.80	Output current of LDO is equal to input current
LDO	VDD_1V0	1.00	10.90	10.90	
LDO	VCC3V0_PMU	3.01	1.20	1.20	
battery	VBAT	3.81	94.60	92.67	Theoretical value is similar to actually measured value

## 3.2 Compare with EVB data

Break down the power consumption data of each path, compare with the data of EVB in the same scenario, and check if there is problem. For example, the following is the comparison of the static desktop power consumption between RK3326 EVB board and customer device, it can be seen that customer board's power consumption of ARM and LOG are abnormal, and need to analyze further.



Type	power-supply	EVb		Customer device	
		Voltage(V)	Current(mA)	Voltage(V)	Current(mA)
DC/DC	VDD_ARM	0.96	10.20	1.10	212.50
DC/DC	VDD_LOG	0.96	89.30	1.00	151.30
DC/DC	VCC_DDR	1.26	38.50	1.27	40.50
DC/DC	VCC_IO	2.99	4.50	2.99	4.80
LDO	VCC_1V8	1.81	28.80	1.81	29.80
LDO	VDD_1V0	1.00	10.90	1.00	10.20
LDO	VCC3V0_PMU	3.01	1.20	3.01	1.40
battery	VBAT	3.81	94.60	3.81	191.6

### 3.3 Data analysis for each path

#### 3.3.1 VDD\_CORE/VDD\_CPU/VDD\_ARM

These three names are the same power, that is, ARM core power. This power consumption can be analyzed mainly from the following aspects:

- Confirm if the frequency voltage table (opp-table) is normal or not, if the actually measured voltage is consistent with the set voltage or not.

Relative commands are as below:

```

1  /* Acquire the frequency voltage table, target column means the voltage
   required by some frequency */
2  cat /sys/kernel/debug/opp/opp_summary
3  device          rate(Hz)    target(uV)    min(uV)    max(uV)
4  -----
5  ...
6  cpu0
7              408000000      950000      950000      1350000
8              600000000      950000      950000      1350000
9              816000000     1000000     1000000      1350000
10             1008000000     1125000     1125000      1350000
11             1200000000     1275000     1275000      1350000
12             1248000000     1300000     1300000      1350000
13             1296000000     1350000     1350000      1350000
14
15 /* Check the frequency scaling strategy currently used by cpufreq, cpu
   frequency scaling is enabled with the default interactive strategy */
16 cat /sys/devices/system/cpu/cpu0/cpufreq/scaling_governor
17 interactive
18
19 /* Set userspace strategy to fix the frequency of cpu, then set different
   frequencies, compare the set voltage with the measured voltage */
20 echo userspace > /sys/devices/system/cpu/cpu0/cpufreq/scaling_governor
21 cat /sys/devices/system/cpu/cpu0/cpufreq/scaling_governor
22 userspace
23

```



```

24 /* Check the frequency point supported by cpufreq */
25 cat /sys/devices/system/cpu/cpu0/cpufreq/scaling_available_frequencies
26 408000 600000 816000 1008000 1200000 1248000 1296000
27
28 /* Set the fixed frequency */
29 echo 408000 > /sys/devices/system/cpu/cpu0/cpufreq/scaling_setspeed
30
31 /* Confirm current frequency*/
32 cat /sys/devices/system/cpu/cpu0/cpufreq/scaling_cur_freq
33 408000
34
35 /* Confirm current voltage, and compare with measured value, vdd_arm
36 represents the name of regulator, which is different for different projects*/
37 cat /sys/kernel/debug/regulator/vdd_arm/voltage
38 950000
39
40 /* Acquire current voltages of all regulators*/
41 cat /sys/kernel/debug/regulator/regulator_summary
42 regulator                use open bypass voltage current      min
43 max
44 -----
45 ---
46 ...
47 vcc3v8_sys                0    12        0  3800mV      0mA  3800mV
48 3800mV
49 deviceless                0    0          0    0mV        0mA  0mV
50 0mV
51 vdd_logic                 0     4        0   950mV      0mA  950mV
52 1350mV
53 dmc                       0     0          0    0mV        0mA  950mV
54 1350mV
55 ff400000.gpu              0     0          0    0mV        0mA  950mV
56 1350mV
57 bus-apll                  0     0          0    0mV        0mA  950mV
58 1350mV
59 deviceless                0     0          0    0mV        0mA  0mV
60 0mV
61 vdd_arm                   0     2        0   950mV      0mA  950mV
62 1350mV
63 cpu0                      0     0          0    0mV        0mA  950mV
64 1350mV
65 deviceless                0     0          0    0mV        0mA  0mV
66 0mV
67 ...

```

- Check cpu loading, analyze if there is irregular task or interrupt.

```

1 /* Use top command to check the task loading, the output of top with
2 different versions will have difference, this version of top supports to
3 check the thread and the running cpu of the thread */
4 top -m 5 -t
5 User 51%, System 2%, IOW 0%, IRQ 0%
6 User 712 + Nice 0 + Sys 33 + Idle 634 + IOW 0 + IRQ 0 + SIRQ 0 = 1379

```

```

6  /* PR column represents currently running cpu of the thread, the sum of all
   cpu loading percentage is equal to 100%, so the highest loading percentage
   of each cpu is 100%/NR_CPU, the highest loading percentage of each CPU of
   SoC with 4 cores is 25% */
7  PID   TID  PR CPU% S      VSS      RSS PCY UID      Thread      Proc
8  2631  2631  3   25% R    3104K    552K   fg root    busybox     busybox
9  2632  2632  2   25% R    3104K    552K   fg root    busybox     busybox
10 2633  2633  1    3% R     740K    400K   fg root    top
   /data/top
11  255   476  0    0% S   15492K   4988K   fg system  HwBinder:255_1
   /vendor/bin/hw/android.hardware.sensors@1.0-service
12  419   478  1    0% S  3770752K 256884K fg system  SensorService
   system_server
13
14 /* Use cpustats to observe the frequency change of cpu */
15 cpustats
16 Total: User 600 + Nice 0 + Sys 3 + Idle 591 + IOW 0 + IRQ 0 + SIRQ 0 = 1194
17 408000kHz 0 +
18 600000kHz 0 +
19 816000kHz 0 +
20 1008000kHz 0 +
21 1200000kHz 0 +
22 1248000kHz 0 +
23 1296000kHz 0 +
24 1416000kHz 0 +
25 1512000kHz 1200 = 1200 /* within the statistic time, there are 1200
   system jiffies in total, 1512M running for 1200 jiffies */
26 /* from below, we can see the loading status of each cpu, including user
   mode, kernel mode, interrupt and idle time */
27 cpu0: User 0 + Nice 0 + Sys 1 + Idle 294 + IOW 0 + IRQ 0 + SIRQ 0 = 295
28 cpu1: User 299 + Nice 0 + Sys 1 + Idle 0 + IOW 0 + IRQ 0 + SIRQ 0 = 300
29 cpu2: User 1 + Nice 0 + Sys 1 + Idle 296 + IOW 0 + IRQ 0 + SIRQ 0 = 298
30 cpu3: User 300 + Nice 0 + Sys 1 + Idle 0 + IOW 0 + IRQ 0 + SIRQ 0 = 301
31
32 /* check the ratio of running time for each frequency through cpufreq node,
   time unit: jiffies */
33 cat /sys/devices/system/cpu/cpu0/cpufreq/stats/time_in_state
34 408000 718186
35 600000 548
36 816000 368
37 1008000 1578
38 1200000 1104
39 1248000 84
40 1296000 101
41 1416000 678
42 1512000 47495
43
44 /* check the interrupt quantity of all peripherals */
45 cat /proc/interrupts
46          CPU0          CPU1          CPU2          CPU3
47 1:          0            0            0            0      GICv2 29 Edge
   arch_timer
48 2:      181898      165057      636772      839244      GICv2 30 Edge
   arch_timer
49 5:      180743       39000       28905       65189      GICv2 62 Level
   rk_timer
50 13:      260634          0            0            0      GICv2 39 Level
   ff180000.i2c

```

51	14:	354805	0	0	0	GICv2	40	Level
		ff190000.i2c						
52	15:	0	0	0	0	GICv2	41	Level
		ff1a0000.i2c						
53	...							

### 3.3.2 VDD\_GPU

The power consumption of VDD\_GPU mainly confirms if the the frequency voltage table is normal or not, if the measured voltage is consistent with the set voltage or not, using devfreq node.

*Note: some chips' GPU module doesn't have separate VD and it will put GPU in VDD\_LOGIC, here is needed to confirm if the voltage of VDD\_LOGIC is normal or not.*

```

1  /* acquire the frequency voltage table */
2  cat /sys/kernel/debug/opp/opp_summary
3      device                rate(Hz)    target(uV)    min(uV)    max(uV)
4  -----
5  ...
6  platform-ff400000.gpu
7              200000000        950000        950000        950000
8              300000000        950000        950000        950000
9              400000000       1025000       1025000       1025000
10             480000000       1100000       1100000       1100000
11             520000000       1150000       1150000       1150000
12  ...
13
14 /* check the frequency scaling strategy currently used by gpu devfreq, gpu
15    frequency scaling is enabled with the default simple_ondemand strategy */
16 cat /sys/class/devfreq/ff400000.gpu/governor
17 simple_ondemand
18 Note: ff400000 of ff400000.gpu is the address of gpu register, so the name
19    will be different for differnt chips.
20
21 /* Set userspace strategy to fix the frequency of gpu, then set different
22    frequencies, compare the set voltage with measured voltage */
23 echo userspace > /sys/class/devfreq/ff400000.gpu/governor
24 cat /sys/class/devfreq/ff400000.gpu/governor
25 userspace
26
27 /* check the frequency points supported by gpu devfreq */
28 cat /sys/class/devfreq/ff400000.gpu/available_frequencies
29 520000000 480000000 400000000 300000000 200000000
30
31 /* set the fixed frequency */
32 echo 200000000 > /sys/class/devfreq/ff400000.gpu/userspace/set_freq
33
34 /* confirm current frequency */
35 cat /sys/class/devfreq/ff400000.gpu/cur_freq
36 200000000
37
38 /* confirm current voltage, and compare with measued value */
39 cat /sys/kernel/debug/regulator/vdd_gpu/voltage
40 950000
41
42 /* check gpu loading */
43 cat /sys/class/devfreq/ff400000.gpu/load

```

### 3.3.3 VDD\_LOGIC

Generally VDD\_LOGIC will contain many modules, in order to manage the power consumption conveniently, it will be divided into many PD internally. The power consumption can be analyzed mainly from the following aspects:

- Confirm the running frequency and switch status of each module.

```

1 cat /sys/kernel/debug/clk/clk_summary
2   clock                                enable_cnt  prepare_cnt    rate
3   accuracy  phase
4   -----
5   xin24m                                9           10    24000000
6   0 0
7   ...
8   pll_gp1l                             1           1    120000000
9   0 0
10  gp1l                                9          20    120000000
11  0 0
12  clk_sdio_div50                       1           1    100000000
13  0 0
14  clk_sdio                             1           5    100000000
15  0 0
16  sdio_sample                          0           1     50000000
17  0 0
18  sdio_drv                             0           1     50000000
19  0 180
20  clk_emmc_div50                       1           1     30000000
21  0 0
22  clk_emmc                             1           5     30000000
23  0 0
24  emmc_sample                          0           1     15000000
25  0 42
26  emmc_drv                             0           1     15000000
27  0 180
28  ...

```

- Confirm the switch status of each PD.

```

1 cat /sys/kernel/debug/pm_genpd/pm_genpd_summary
2   <
3   domain                                status      slaves
4   /device                                runtime status
5   -----
6   pd_gpu                                off
7   /devices/platform/ff400000.gpu          suspended
8   pd_vi                                off
9   /devices/platform/ff4a8000.iommu        suspended
10  pd_vo                                on
11  /devices/platform/ff460f00.iommu         active
12  /devices/platform/ff470f00.iommu         suspended
13  /devices/platform/ff2e0000.video-phy     suspended
14  /devices/platform/ff450000.dsi           active

```

14	/devices/platform/ff460000.vop	active
15	/devices/platform/ff470000.vop	suspended
16	/devices/platform/ff480000.rk_rga	suspended
17	pd_vpu	off
18	/devices/platform/ff440440.iommu	suspended
19	/devices/platform/ff442800.iommu	suspended
20	/devices/platform/vpu_combo	suspended
21	pd_mmc_nand	on
22	/devices/platform/ff380000.dwmmc	unsupported
23	/devices/platform/ff390000.dwmmc	unsupported
24	/devices/platform/ff3b0000.nandc	active
25	pd_gmac	off
26	pd_sdcard	off
27	pd_usb	on
28	/devices/platform/ff300000.usb	active

- Generally DDR module is put in VDD\_LOGIC, and the power consumption of DDR module is relatively large, use the same devfreq strategy as GPU to optimize the power consumption, so need to confirm the frequency voltage table and measured voltage. DDR also has some configurations with low power consumption, such as pd\_idle, sr\_idle, odt switch and some other timing configurations. The debugging process is relatively complex, you need to refer to the detailed DDR document.

```

1 cat /sys/kernel/debug/opp/opp_summary
2 device          rate(Hz)    target(uV)    min(uV)    max(uV)
3 -----
4 platform-dmc
5                194000000    950000       950000     950000
6                328000000    950000       950000     950000
7                450000000    950000       950000     950000
8                528000000    975000       975000     975000
9                666000000    1000000      1000000     1000000
10 ...
11
12 /* ddr uses dmc_ondemand frequency scaling strategy by default */
13 cat /sys/class/devfreq/dmc/governor
14 dmc_ondemand
15
16 Other commands to set the frequency and voltage are the same as GPU
   devfreq.
```

### 3.3.4 VCC\_DDR

VCC\_DDR supplies power mainly for DDR component and DDR-IO part of SoC. The parameters affecting the power consumption of VCC\_DDR include: DDR frequency, DDR loading, DDR low power consumption configuration, DDR component type and so on. Under the same condition, the power consumption of DDR components from different vendors may have big difference.

### 3.3.5 VCC\_IO

VCC\_IO supplies power mainly for IO Pad of SoC and some peripherals. The power consumption can be analyzed from the following aspects:

- Check the working status of peripheral module, if there is leakage.
- Check if IO pin status of SoC matches with the peripheral or not, for example, IO output is high, but the connected peripheral pin is low level.

## 3.4 Common scenario analysis

### 3.4.1 Static desktop

It is mainly the display module which is working, CPU, GPU, DDR should be reduced to the lowest frequency, and enter low power consumption mode. Adjust VDD\_CPU,VDD\_GPU,VDD\_LOGIC to the lowest voltage of opp-table, confirm the status of clk\_summary and pm\_genpd\_summary, confirm the peripheral modules (WIFI, BT, etc.) are all closed. The static desktop generally is used as the basic power consumption of other scenarios, so need to firstly optimize its power consumption to the best.

### 3.4.2 Video playback

It is mainly the video decoder (VPU/RKVDEC) which is working, GPU generally is closed. Especially confirm if the running frequency of DDR and voltage of VDD\_LOGIC are normal or not.

### 3.4.3 Game

It is mainly CPU and GPU which are working. Especially analyze the loading of CPU and GPU, frequency change, the voltages of VDD\_CPU and VDD\_GPU are normal or not.

### 3.4.4 Deepsleep

Generally VDD\_CPU and VDD\_GPU will turn off the power supply, VDD\_LOG only reserves the power supply for some resume module, so need to focus on the power consumption analysis of IO, DDR components and some peripherals.

## 4. Power consumption optimization strategy

### 4.1 CPU optimization

- Adjust cpufreq parameter.

```
1  /* the default frequency scaling strategy used is interactive, relative
2  parameters are as follows: */
3  ls -l /sys/devices/system/cpu/cpu0/cpufreq/interactive
4  go_hispeed_load      /* when the loading is larger than go_hispeed_load and
5  the frequency is smaller than hispeed_freq, directly jump to hispeed_freq
6  */
7  hispeed_freq         /* when jumping from low frequency to high frequency,
8  need to jump to hispedd_freq first */
9  above_hispeed_delay /* when the frequency is larger than hispeed_freq, the
10 time duration before each frequency increase */
11 min_sample_time      /* after each frequency increase, if it is to reduce
12 the frequency next time , the time duration before frequency reduce */
13 target_loads         /* the target loading of the frequency scaling */
14 timer_rate           /* the loading sampling time, unit:us */
15 timer_slack          /* the loading sampling time after cpu entering idle */
16 boost                /* when the frequency is smaller than hispeed_freq,
17 keep boost to hispeed_freq */
18 boostpulse           /* when the frequency is smaller than hispeed_freq,
19 boost to hispeed_freq, keep a while */
20 boostpulse_duration /* time duration of boostpulse, unit:us */
21 io_is_busy           /* whether to compute io wait to cpu loading */
22
23 we mainly adjust three parameters: hispeed_freq, target_loads, timer_rate:
```

```

16
17 1. hispeed_freq: select an appropriate transition frequency, to make cpu
    stable in the medium frequency, with the best power consumption, too large
    or too small will cause cpu jump to high frequency easily and increase the
    power consumption.
18 2. target_loads: easier to run with low frequency after this value is
    increased, both the power consumption and the performance will be reduced.
19 3. timer_rate: easier to run with low frequency after this value is
    increased, both the power consumption and the performance will be reduced.

```

- Close some cpu, limit the highest frequency of cpu.

```

1  /* close cpu2, cpu3 */
2  echo 0 > /sys/devices/system/cpu/cpu2/online
3  echo 0 > /sys/devices/system/cpu/cpu3/online
4
5  /* set the max frequency of cpu0 to 1200MHz */
6  echo 1200000 > /sys/devices/system/cpu/cpu0/cpufreq/scaling_max_freq

```

- SoC with ARM Big-Little architecture can bind the tasks with high loading to little cores through CPuset since the energy efficiency of the little core is better.

/\* Note: SoC with SMP architecture can also bind the tasks to some cpu so that other cpus can enter low power consumption mode, but maybe it will make cpu easy to run with high frequency, which will increase the power consumption. \*/

```

1  /* create group of little core*/
2  mkdir /dev/cpuset/little
3
4  /* set cpu used by group of little core */
5  echo 0-3 > /dev/cpuset/little/cpus
6
7  /* add pid=1111 task into the group of little core */
8  echo 1111 > /dev/cpuset/little/tasks
9
10 /* Android system creates several groups by default, the framework layer
    puts the tasks into different groups, you can adjust cpus of each group,
    analyze the power consumption */
11 ls /dev/cpuset
12 background
13 foreground
14 system-background
15 top-app

```

- Limit the cpu bandwidth of the tasks with high loading through CPUCTL (need to enable the macro CONFIG\_CFS\_BANDWIDTH).

```

1  /* create the group of bandwidth limitation */
2  mkdir /dev/cpuctl/mygroup
3
4  /* set the cycle of bandwidth limitation as 10ms */
5  echo 10000 > /dev/cpuctl/mygroup/cpu.cfs_quota_us
6

```



```

7  /* within each cycle, total running time of the tasks in the group cannot
   exceed 5ms, this value can be larger than cfs_quota_us, because it is the
   total running time of multiple cpus */
8  echo 5000 > /dev/cpuctl/mygroup/cpu.cfs_period_us
9
10 /* add relative tasks into the group */
11 echo 1111 > /dev/cpuctl/mygroup/tasks
12 echo 1112 > /dev/cpuctl/mygroup/tasks
13
14 /* cpu.shares means to limit the bandwidth of the task through weight, used
   for performance optimization, without affecting the power consumption */
15 /dev/cpuctl/mygroup/cpu.shares

```

## 4.2 DDR optimization

- Frequency scaling with scenario: configure different DDR frequencies for different scenarios, such as 4K video, video recording, dual display and so on.

```

1  /* scenario definition */
2  include/dt-bindings/clock/rk_system_status.h
3  #define SYS_STATUS_NORMAL      (1<<0)
4  #define SYS_STATUS_SUSPEND     (1<<1)
5  #define SYS_STATUS_IDLE       (1<<2)
6  #define SYS_STATUS_REBOOT     (1<<3)
7  #define SYS_STATUS_VIDEO_4K   (1<<4)
8  #define SYS_STATUS_VIDEO_1080P (1<<5)
9  ...
10
11 /* configure the frequencies for different scenarios in dts */
12 arch/arm64/boot/dts/rockchip/px30.dtsi
13 dmc: dmc {
14     compatible = "rockchip,px30-dmc";
15     ...
16     system-status-freq = <
17         /*system status      freq(KHz)*/
18         SYS_STATUS_NORMAL    528000
19         SYS_STATUS_REBOOT    450000
20         SYS_STATUS_SUSPEND    194000
21         SYS_STATUS_VIDEO_1080P 450000
22         SYS_STATUS_BOOST     528000
23         SYS_STATUS_ISP       666000
24         SYS_STATUS_PERFORMANCE 666000
25     >;
26     ...
27
28 /* acquire the current scenario */
29 cat /sys/class/devfreq/dmc/system_status
30 0x401

```

- Frequency scaling with loading: monitor the loading, automatically adjust DDR frequency, frequency scaling with loading may cause the reduction of the performance, you can fix DDR frequency in some scenario considering the frequency scaling with scenario.

```

1  /* configure the parameter of frequency scaling with loading in dts, need
   to open dfi node to monitor DDR utility ratio */
2  dmc: dmc {

```

```

3     compatible = "rockchip,px30-dmc";
4     ...
5
6     /* use dfi to monitor the utility ratio of DDR */
7     devfreq-events = <&dfi>;
8
9     /*
10      * the threshold of frequency scaling:
11      * when the utility ratio is over 40%, adjust to the highest frequency.
12      * when the loading is less than 40% and larger than 40%-20%, maintain
13      current frequency.
14      * when the loading is less than 40%-20%, it will adjust the frequency
15      to a certain value to make the loading to be around 40%-2%/2.
16      */
17     upthreshold = <40>;
18     downthreshold = <20>;
19
20 /* check the DDR loading of current system */
21 cat /sys/class/devfreq/dmc/load
22 33@528000000Hz

```

- For more detailed configuration and optimization of DDR DEVFREQ, please refer to the document 《Rockchip-Developer-Guide-Linux4.4-Devfreq》.

## 4.3 Thermal control optimization

When the temperature is increasing to certain degree, the power consumption will increase dramatically, especially in the case with high voltage.

- Improve the heat dissipation of hardware.
- Optimize the software thermal control strategy to avoid the big temperature fluctuation.
- Avoid the high voltage occurring in the case with high temperature through software limitation.

```

1 &cpu0_opp_table {
2     /* when the temperature is over 85 degree, limit the max voltage of cpu
3     to 1.1V */
4     rockchip,high-temp = <85000>;
5     rockchip,high-temp-max-volt = <1100000>;
6
7     /* or directly limit the max frequency to avoid the high voltage */
8     rockchip,high-temp-max-freq = <1008000>;
9 };

```

## 4.4 Power optimization

- In voltage conversion circuit, when the voltage reduction and current are relatively large, it is recommended to use DCDC to improve the efficiency and reduce the power consumption.

For example:

Input 3.3V, output 1.0V-50mA

Power Type	Input Current	Power Consumption
LDO	50mA	165mW
DCDC(with 80% efficiency)	18.9mA	62.4mW